

<b>Notice of References Cited</b>	Application/Control No. 10/716,404	Applicant(s)/Patent Under Reexamination MIKAWA, TAKUMA	
	Examiner HELEN SHIBRU	Art Unit 2621	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0065780	03-2008	Iwata et al.	709/231
*	B	US-7,209,643	04-2007	Sato et al.	386/95
*	C	US-2006/0265421	11-2006	Ranasinghe et al.	707/104.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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**NON-PATENT DOCUMENTS**

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